

Analysis of drawbacks and reconstruction problems of the R2-type train

Laugis, Juhan; Vinnikov, Dmitri; Boiko, Vitali The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 355-358 : ill

Analysis of peak current for current crowding effect in 4H- and 6H-SiC Schottky structures

Kurel, Raido; Rang, Toomas The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 235-236 : ill

An analytical approach to low-power gated-clock finite-state machine solutions

Liiver, Aimar; Tammemäe, Kalle; Kruus, Margus The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 67-70 : ill

A brief survey of exciton concentration models for Si

Velme, Enn; Udal, Andres The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 19-22 : ill

The class of test signals for dynamic testing of AD converters

Land, Raul The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 127-128 : ill

CMOS SP chip for resistor type semiconductor gas sensors

Kasemaa, Argo; Rang, Toomas The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 255-256 : ill

Combining learning, training and research in laboratory course for design and test

Ubar, Raimund-Johannes; Orasson, Elmet; Raik, Jaan; Wuttke, Heinz-Dietrich The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 221-224 : ill

https://www.researchgate.net/publication/242397131_Combining_Learning_Training_and_Research_in_Laboratory_Course_for_Design_and_Test

Commutation processes in the diode bridge of resonant converter with alternating parallel and series resonance

Janson, Kuno; Järvik, Jaan; Vinnal, Toomas The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 205-208 : ill

Comparative characteristics of diffusion welded Al contacts to 6H- and 4H-SiC substrates

Korolkov, Oleg; Rang, Toomas The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 23-26 : ill

Design of three-rate continuous-time subcontrollers for the multidimensional stochastic state-space model of an experimental aircraft

Astrov, Igor; Pedai, Andrus; Rüstern, Ennu The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 277-280 : ill

Design of two-rate decentralized linear quadratic regulators for continuous-time stochastic multivariable control systems

Astrov, Igor; Em, Juri; Rüstern, Ennu The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 273-276 : ill

Design of two-rate stochastic multivariable discrete-time control systems

Astrov, Igor; Rüstern, Ennu The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 79-82 : ill

Fault oriented test pattern generation for sequential circuits using Genetic Algorithms

Ivask, Eero; Raik, Jaan; Ubar, Raimund-Johannes The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 129-132 : ill

Fault prediction in power network

Kangilaski, Taivo The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 289-292

Finite state machine synthesis for low power using input-disabling precomputation architectures

Sudnitsõn, Aleksander The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 137-140 : ill

FSM decomposition using shift registers

Kruus, Margus; Lensen, Harri The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 141-144 : ill

Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 141-144 : ill

Genetic algorithms in transparent fuzzy modeling

Riid, Andri; Jartsev, Pavel; Rüstern, Ennu The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 91-94 : ill

Greedy alternative for the static compaction of sequential circuit test sequences

Raik, Jaan The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 133-136 : ill

Hierarchical fault simulation for finite state machines

Brik, Marina; Raik, Jaan; Ubar, Raimund-Johannes The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 145-148 : ill

High power factor single- and three-phase diode rectifiers using parallel re-rectification of the ripple power

Sakkos, Tiiu; Sarv, Vello The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 199-202 : ill

Increasing the speed of delay simulation in digital circuits

Ubar, Raimund-Johannes; Jutman, Artur The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 31-34 : ill

Kalman Tarnay (1929 - 1998)

Rang, Toomas The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. V : portr

Low power SC structures with low threshold MOS switches

Männama, Vello; Sabolotny, Rein The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 75-78 : ill

LPE structures for power GaAs rectifiers

Voitovitš, Viktor The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 237-240 : ill
https://artiklid.elnet.ee/record=b1005558*est

Mapping of VHDL structures for generic EDA database format IRSYD

Ivask, Eero; Ellervee, Peeter The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 317-320 : ill

Mechatronics in initial vocational training

Rosin, Argo; Lehtla, Tõnu; Laugis, Juhan The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 225-228 : ill

A modified frequency error estimator for the block adaptive Fourier analyzer

Ronk, Ants The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 103-106 : ill https://www.ester.ee/record=b2150914*est

Negative resistance structures : optimization of power balance

Taniloo, Rainer The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 353-354 : ill

The neural network classification algorithms with applications to averaged EEG data

Raja, Aimur; Tuulik, Viuu; Lossmann, Eerik; Meister, Ants The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 347-348

Numerical calculations of electrotechnics

Liivik, Liisa; Jansikene, Raik The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 229-230 : ill

Phase-frequency detector modeling for the PLL applications

Männama, Vello; Paavle, Toivo The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 119-122 : ill

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Rang, Toomas The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. III https://www.eester.ee/record=b2150914*est

Preliminary approach to the timing measurements for reverse recovery applied to the SiC Schottky diode model

Pikkov, Mihhail The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 321-322 : ill

RF power amplifier control curve approximation

Koort, Marko The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 71-74 : ill

Signal distortions caused by multipath propagation in DAB transmission

Meister, Ants; Lossmann, Eerik; Martverk, Peep The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 337-340 : ill

Simulation of digital systems with high-level decision diagrams

Morawiec, Adam; **Raik, Jaan; Ubar, Raimund-Johannes** The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 35-38 : ill

A spectrum-based technique to analyze a pair of digitized signals

Lossmann, Eerik; Tuulik, Viiu; Meister, Ants; Raja, Aimur The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 177-178 : ill

Tram traction drives and comparison of their control methods

Joller, Jüri; Lehtla, Madis; Lehtla, Tõnu; Laugis, Juhan The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 203-204 : ill

Virtual laboratory for research in dependable microelectronics

Diener, Karl-Heinz; Elst, G.; Gramatova, Elena; Kuzmicz, W.; Peng, Z.; **Ubar, Raimund-Johannes** The 7th Biennial Conference on Electronics and Microsystem Technology "Baltic Electronics Conference" : BEC 2000 : October 8 - 11, 2000, Tallinn, Estonia : conference proceedings 2000 / p. 217-220 : ill